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Broadband Mid Infrared Photonic Integrated components using a Ge-rich SiGe platform

Vladyslav Vakarin¹, Joan Manel Ramirez^{1,*}, Qiankun Liu¹, Xavier Le Roux¹, Jacopo Frigerio², Andrea Ballabio², Laurent Vivien¹, Giovanni Isella², and Delphine Marris-Morini¹

¹Centre de Nanosciences et de Nanotechnologies, CNRS, Univ. Paris-Sud, Université Paris-Saclay, C2N – Orsay, 91405 Orsay cedex, France ²L-NESS, Dipartimento di Fisica, Politecnico di Milano, Polo di Como, Via Anzani 42, 22100 Como, Italy

*e-mail : joan-manel.ramirez@u-psud.fr

Abstract. We demonstrate low-loss mid infrared photonic integrated components fabricated on a Ge-rich Si_{1-x}Ge_x platform. These devices show broadband operation over a wavelength range of at least from $\lambda \approx 5.1 \ \mu m$ to $\lambda \approx 8.6 \ \mu m$, and comprise waveguides, multimode interference couplers and Mach-Zehnder interferometers.

Keywords: Mid infrared; Silicon; Germanium; Integrated photonics; Waveguides; Mach-Zehnder Interferometer.

I. INTRODUCTION

Mid-IR systems are recently gaining attention due to the foreseen outstanding functionality of a large pool of devices upon integration in an efficient, compact and cost-effective platform [1]. Such new approach is expected to provide solutions in many fields including sensing, imaging, healthcare or secure communication networks, among others [2].

To accomplish such a challenging task, mid-IR devices should be processed in a suitable technology yielding robust performance while being able to cope with the processing constraints of the new designs. In that regard, the use of Si-based platforms is particularly interesting, as it provides access to the mainstream CMOS technology. Indeed, the combination of Si and Ge as raw materials either in the form of Ge-on-Si or by using Si_{1-x}Ge_x alloys appears very promising to develop mid-IR photonic integrated circuits (PICs) due to the large transparency window of both materials ($\lambda \approx$ 8 μ m for Si and $\lambda \approx 15 \mu$ m for Ge) and the suppression of Two-Photon Absorption (TPA) at the early mid-IR region ($\lambda \approx 2.2 \ \mu m$ for Si and $\lambda \approx 3.2 \ \mu m$ for Ge) [3, 4]. Moreover, such latter advantage can be leveraged to design active devices by taking advantage of the Si and Ge third-order optical susceptibility with no TPA penalty under high pumping regime [5, 6]. Within this framework we recently demonstrated the potential of Ge-rich Si_{0.2}Ge_{0.8} waveguides on graded substrates for the development of new mid-IR circuits, and we reported low propagation loss of 1.5+/-0.5 dB/cm at 4.6 µm wavelength [7].

We now report on the development of a series of mid-IR components and interferometric devices, using this Ge-rich $Si_{1-x}Ge_x$ platform. As a main advantage we demonstrate flat response in a wide spectral range, from 5.1 to 8.6 µm wavelength, only limited by the experimental set-up. This work opens new perspectives

for operation in an ultra-wide spectral range in the mid-IR.

II. DEVICE DESIGN AND FABRICATION

The devices are based on the Ge-rich $Si_{1-x}Ge_x$ epilayer reported in figure 1. A 11µm-thick graded buffer layer with a linear increase of the Ge concentration from x = 0 up to x = 0.79 was deposited over a Si substrate by Low Energy Plasma Enhanced Chemical Vapour Deposition (LEPECVD). Then, a 2 µm-thick $Si_{0.2}Ge_{0.8}$ layer was grown on top, to be used as the guiding core. Such configuration provides a gradual accommodation of the lattice parameter along the vertical direction, resulting in a low threading dislocation density (TDD) of around 3×10^6 cm⁻² and therefore a high quality platform to develop photonic devices [7].

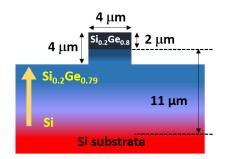


Fig.1 (a) Representative waveguide cross-section scheme using the Ge-rich $Si_{1,x}Ge_x$ platform.

The mid-IR devices are based on the waveguide cross-section displayed in figure 1. The waveguide width is 4 μ m and the etching depth is 4 μ m. The waveguides are enlarged at the input/output of the photonic integrated circuit, up to a width of 50 μ m in order to provide good fiber-waveguide mode matching. Additionally, adiabatic tapers were designed, followed by a single mode waveguide region to filter out higher order propagation modes. Within this platform a large variety of devices can be implemented, such as resonators, spirals waveguides, or interferometric structures.

III. CHARACTERIZATION

We report here the characterization of asymmetric Mach Zehdner Interferometer (MZIs). The Mach Zehnders arms are 3.2mm-long, with a length difference of 48μ m between both arms. Multimode Intereferometers have been designed as couplers/combiners for the studied wavelength range.

Devices were characterized using the experimental setup described in figure 2. The mid-IR source is a tunable MIRCAT laser, using external Cavity Quantum Cascade Lasers working in pulsed operation (repetition rate of 100 kHz and a duty cycle of 5 %), which provide a maximum peak intensity of 300 mW around of 6.5 µm and cover the wavelength range from 5.1 μ m to 8.6 μ m. The output beam is then coupled to a single mode micro-structured fiber for waveguide butt-coupling. Α free-space collection system composed by an aspheric lens and a series of mirrors was used to collect and drive the output signal towards the polarizer first and then towards the MCT detector of a mid-IR spectrometer. A lock-in amplifier synchronizes the collected signal with the laser pulses. Samples were characterized in quasi-TM polarization.

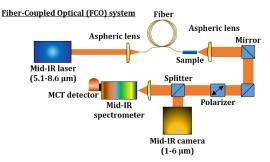


Fig.2. Experimental setup used to characterize the mid infrared devices and components.

Broadband transmission measurements were carried out by sweeping the laser signal all over the available wavelength range, from $\lambda = 5.1 \mu m$ to $\lambda = 8.6 \mu m$ in steps of 1 nm.

As observed in figure 3 (black line), straight waveguides provide flat optical transmission in the entire wavelength range, with coupling losses of around 4 dB/facet and propagation losses < 5 dB/cm regardless of the wavelength. MZIs were characterized with the same procedure. The measured Free Spectral Range (FSR) is related to the length difference between both arms. At least 10 dB of extinction ratio is obtained in the entire wavelength range, demonstrating a broadband robust operation.

Further analysis of these new mid-IR devices will be presented, providing a reasoned explanation of the origin of such broadband operation. Moreover, a route map for future device development (resonators, grating couplers or Fabry-Perot cavities) and more complex mid-IR integrated systems (integrated spectrometers, label-free sensing schemes) using the Ge-rich Si_{1-x}Ge_x platform will be detailed.

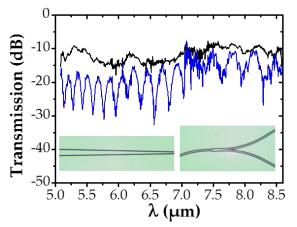


Fig.3. Total waveguide (black line) and MZI (blue line) optical transmission (quasi-TM polarization), comprising coupling and propagation losses. Noticeably, the strong fiber absorption lines around $\lambda \approx 7 \ \mu m$ provide a noisy response in this range. Bottom insets show the fabricated adiabatic taper (left) and the MMI (right).

IV. CONCLUSION

Several mid-IR photonic integrated components have been demonstrated using a Ge-rich Si_{1-x}Ge_x approach. Spiral waveguides, adiabatic tapers, multimode interference couplers and Mach-Zehnder interferometers have been designed, fabricated and characterized, showing broadband robust operation over the entire available wavelength range from $\lambda \approx$ 5.1 µm to $\lambda \approx 8.6$ µm. These results provide a solid basis to develop a competitive mid-IR integrated platform which could potentially exploit the complete Ge transparency window, up to $\lambda \approx 15$ µm.

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